## Multi-frequency Electrical Impedance Tomography for Anomaly Detection and Imaging

## Habib Zribi<sup>†</sup>

†Department of Biomedical Engineering, Kyung Hee University, Korea

Multi-frequency electrical impedance tomography (EIT) systems can be used for both frequency-difference imaging and anomaly detection. We formulate the forward problem as a pair of partial differential equations coupled through conductivity  $\sigma$  and permittivity  $\epsilon$  distributions:  $\nabla \cdot (\sigma \nabla v) - \nabla \cdot$  $(\omega \epsilon \nabla h) = 0$  and  $\nabla \cdot (\omega \epsilon \nabla v) + \nabla \cdot (\sigma \nabla h) = 0$  with appropriate boundary conditions where v and h are real and imaginary parts of a complex voltage U = v + ih. Here, we note that both  $\sigma$  and  $\epsilon$  affect v and h. We describe a mathematical analysis of the coupled equations for anomaly detection and frequency-difference imaging. Explaining algorithms for anomaly detection and imaging, we present experimental results using conductivity phantoms.